## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination HYON, SEUNG-TAEK Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0158734 A1	08-2003	CRUICKSHANK, BRIAN	704/260
	В	US-2004/0070567 A1	04-2004	Longe et al.	345/156
	ပ	US-6,324,511 B1	11-2001	Kiraly et al.	704/260
	D	US-6,064,383 A	05-2000	Skelly, Timothy C.	715/758
	Ε	US-2004/0002325 A1	01-2004	Evans et al.	455/414.1
	F	US-			
	G	US-			
	٠Н	US-			
	-	US-			
4	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q		·			
	R					
	S					
	Ţ					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
-	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.